HYM572103 N-Series
1M x 72-bit CMOS DRAM MODULE

DESCRIPTION

The HYM572103 is a 1M x 72-bit Fast page mode CMOS DRAM module consisting of sixteen HY514400A in 20/26 pin SOJ or TSOP-II two HY514403B in 24/26 pin SOJ or TSOP-II and two 16-bit BiCMOS line driver in TSSOP on a 168 pin glass-epoxy printed circuit board. 0.22μF decoupling capacitor is mounted for each DRAM.
The HYM572103NG/TNG/LMG/LTMG is Gold plated socket type Dual In-line Memory Modules suitable for easy interchange and addition of 8M byte memory.

FEATURES

- **Low power dissipationm**
  Max. battery back-up 50.6mW (L-part)
  Max. CMOS standby 41.25mW (L-part)
  121mW
  Max. TTL standby 209mW
  Max. operating

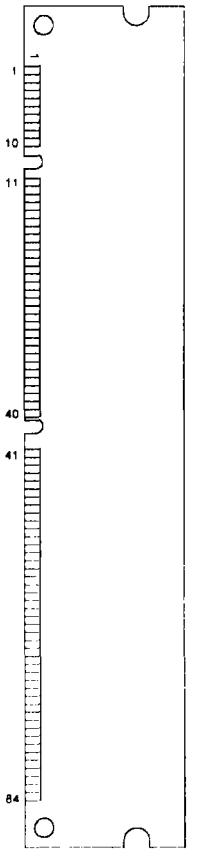
Speed	Power
50	12.89W
60	11.46W
70	10.03W

- **Single power supply of 5V± 10%**
- **TTL compatible Inputs and outputs**
- **Fast access time**

Speed	tRAC	tCAC	tPC
50	50ns	20ns	35ns
60	60ns	20ns	40ns
70	70ns	25ns	45ns

- **Fast page mode operation**
- **$\overline{CAS}$-before-$\overline{RAS}$, $\overline{RAS}$-only and Hidden refresh**
- **1024 refresh cycles / 128ms (L-part)**
- **1024 refresh cycles / 16ms**
- **Buffered Inputs (except $\overline{RAS}$ and DQ)**
- **4 Byte Interleave enabled, Dual address Inputs(A0,B0)**

PIN CONNECTION



PIN DESCRIPTION

$\overline{RAS0}$,$\overline{RAS2}$	Row Address Strobe
$\overline{CAS0}$-$\overline{CAS7}$	Column Address Strobe
$\overline{WE0}$,$\overline{WE2}$	Write Enable
$\overline{OE0}$,$\overline{OE2}$	Output Enable
A0-A9,B0	Address Input
DQ0-DQ71	Data Input/Output
PD1-PD8	Presence Detect
$\overline{PDE}$	Presence Detect Enable
ID0,ID1	ID Bit
Vcc	Power (+ 5V)
Vss	Ground

PIN NAME

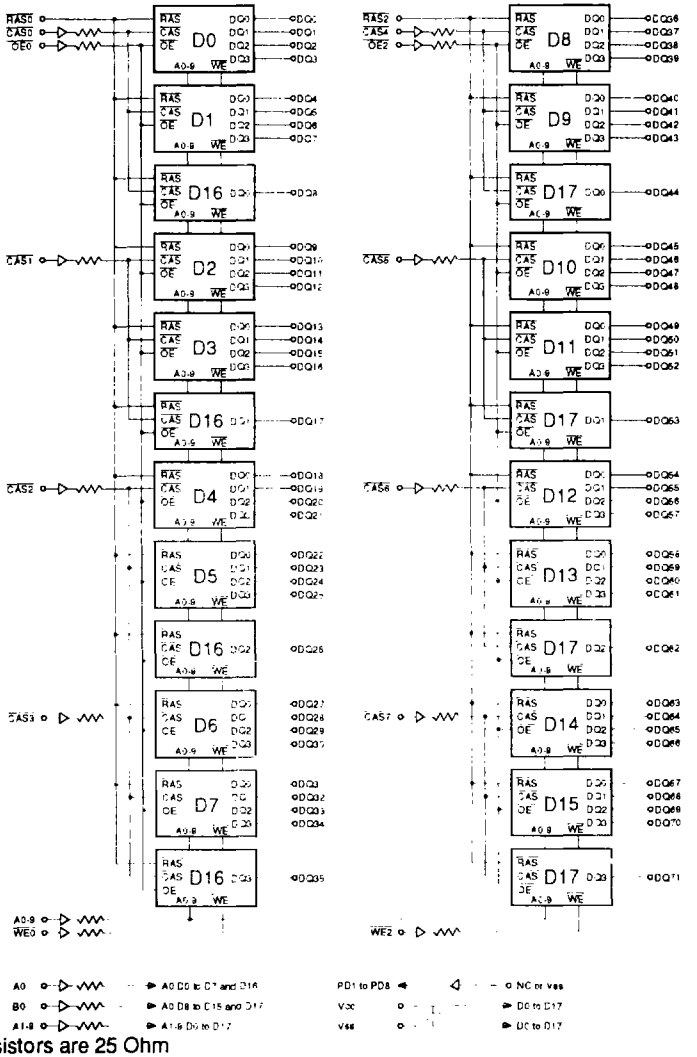
#	NAME	#	NAME	#	NAME	#	NAME
1	Vss	43	Vss	85	Vss	127	Vss
2	DQ0	44	$\overline{OE2}$	86	DQ36	128	NC
3	DQ1	45	$\overline{RAS2}$	87	DQ37	129	NC
4	DQ2	46	$\overline{CAS4}$	88	DQ38	130	$\overline{CAS5}$
5	DQ3	47	$\overline{CAS6}$	89	DQ39	131	$\overline{CAS7}$
6	Vcc	48	$\overline{WE2}$	90	Vcc	132	$\overline{PDE}$
7	DQ4	49	Vcc	91	DQ40	133	Vcc
8	DQ5	50	NC	92	DQ41	134	NC
9	DQ6	51	NC	93	DQ42	135	NC
10	DQ7	52	DQ18	94	DQ43	136	DQ54
11	DQ8	53	DQ19	95	DQ44	137	DQ55
12	Vss	54	Vss	96	Vss	138	Vss
13	DQ9	55	DQ20	97	DQ45	139	DQ56
14	DQ10	56	DQ21	98	DQ46	140	DQ57
15	DQ11	57	DQ22	99	DQ47	141	DQ58
16	DQ12	58	DQ23	100	DQ48	142	DQ59
17	DQ13	59	Vcc	101	DQ49	143	Vcc
18	Vcc	60	DQ24	102	Vcc	144	DQ60
19	DQ14	61	NC	103	DQ50	145	NC
20	DQ15	62	NC	104	DQ51	146	NC
21	DQ16	63	NC	105	DQ52	147	NC
22	DQ17	64	NC	106	DQ53	148	NC
23	Vss	65	DQ25	107	Vss	149	DQ61
24	NC	66	DQ26	108	NC	150	DQ62
25	NC	67	DQ27	109	NC	151	DQ63
26	Vcc	68	Vss	110	Vcc	152	Vss
27	$\overline{WE0}$	69	DQ28	111	NC	153	DQ64
28	$\overline{CAS0}$	70	DQ29	112	$\overline{CAS1}$	154	DQ65
29	$\overline{CAS2}$	71	DQ30	113	$\overline{CAS3}$	155	DQ66
30	$\overline{RAS0}$	72	DQ31	114	NC	156	DQ67
31	$\overline{OE0}$	73	Vcc	115	NC	157	Vcc
32	Vss	74	DQ32	116	Vss	158	DQ68
33	A0	75	DQ33	117	A1	159	DQ69
34	A2	76	DQ34	118	A3	160	DQ70
35	A4	77	DQ35	119	A5	161	DQ71
36	A6	78	Vss	120	A7	162	Vss
37	A8	79	PD1	121	A9	163	PD2
38	NC	80	PD3	122	NC	164	PD4
39	NC	81	PD5	123	NC	165	PD6
40	Vcc	82	PD7	124	Vcc	166	PD8
41	NC	83	ID0(NC)	125	NC	167	ID1(Vss)
42	NC	84	Vcc	126	B0	168	Vcc

PRESENCE DETECT PINS

PIN	PD1	PD2	PD3	PD4	PD5	PD6	PD7	PD8	ID0	ID1
-50	Vss	Vss	NC	Vss	Vss	Vss	Vss	NC	NC	Vss
-60	Vss	Vss	NC	Vss	Vss	NC	NC	NC	NC	Vss
-70	Vss	Vss	NC	Vss	Vss	Vss	NC	NC	NC	Vss

NOTE :
1. PDs are either open NC or driven to Vss via on-board buffer circuits.
2. IDs are connected directly to NC or Vss without a buffer.

BLOCK DIAGRAM



NOTE : All resistors are 25 Ohm

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
T_A	Ambient Temperature	0 to 70	°C
T_{STG}	Storage Temperature	–55 to 150	°C
V_{IN}, V_{OUT}	Voltage on Any Pin Relative to V_{SS}	–1.0 to 7.0	V
V_{CC}	Voltage on V_{CC} Relative to V_{SS}	–1.0 to 7.0	V
I_{OS}	Short Circuit Output Current	50	mA
P_D	Power Dissipation	17.9	W

NOTE : Operation at or above Absolute Maximum Ratings can adversely affect device reliability

RECOMMENDED DC OPERATING CONDITIONS

(T_A= 0°C to 70°C)

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT
V_{CC}	Supply Voltage	4.5	5.0	5.5	V
V_{IH}	Input High Voltage	2.4	-	V_{CC}+ 1.0	V
V_{IL}	Input Low Voltage	–1.0	-	0.8	V

NOTE : All voltages are referenced to V_{SS}.

DC CHARACTERISTICS

(T_A= 0°C to 70°C, V_{CC}= 5V± 10%, V_{SS}= 0V, unless otherwise noted.)

SYMBOL	PARAMETER	TEST CONDITIONS	SPEED/ POWER	MIN.	MAX.	UNIT	NOTE
I_{LI}	Input Leakage Current (Any Input Pin)	$V_{SS} \le V_{IN} \le V_{CC}$+ 0.3, other pins not under test= Vss	All but $\overline{RAS}$	-10	10	µA	
			$\overline{RAS}$	-90	90		
I_{LO}	Output Leakage Current (High Impedance State)	$V_{SS} \le V_{OUT} \le V_{CC}$, $\overline{RAS}$ & $\overline{CAS}$ at V_{IH}		-10	10	µA	
I_{CC1}	V_{CC} Supply Current, Operating	t_{RC}= t_{RC} (min.)	50	-	2344	mA	1,2,3
			60	-	2048		
			70	-	1824		
I_{CC2}	V_{CC} Supply Current, TTL Standby	$\overline{RAS}$ & $\overline{CAS}$ at V_{IH}, other inputs≥ V_{SS}		-	38	mA	
I_{CC3}	V_{CC} Supply Current, $\overline{RAS}$-only refresh	t_{RC}= t_{RC} (min.)	50	-	2344	mA	1,3
			60	-	2048		
			70	-	1824		
I_{CC4}	V_{CC} Supply Current, Fast Page mode	t_{PC}= t_{PC} (min.)	50	-	1484	mA	1,2,3
			60	-	1304		
			70	-	1124		
I_{CC5}	V_{CC} Supply Current, CMOS Standby	$\overline{RAS}$ & $\overline{CAS}$ ≥ V_{CC}–0.2V		-	22	mA	
			L-part		7.5		
I_{CC6}	V_{CC} Supply Current, $\overline{CAS}$-before-$\overline{RAS}$ refresh	t_{RC}= t_{RC} (min.)	50	-	2344	mA	1,3
			60	-	2048		
			70	-	1824		
I_{CC7}	V_{CC} Supply Current, Battery Back Up (L-part only)	t_{RC}= 125µs, $t_{RAS} \le$ 1µs $\overline{CAS}$= CBR cycling or 0.2v, $\overline{OE}$ & $\overline{WE}$= V_{CC} - 0.2V or 0.2V, A0-A9= V_{CC} - 0.2V or 0.2V, DQ0-DQ71= 0.2V, V_{CC} - 0.2V, or open		-	9.2	mA	1,4,5
V_{OL}	Output Low Voltage	I_{OL}= 4.2mA		-	0.4	V	
V_{OH}	Output High Voltage	I_{OH}= –5mA		2.4	-	V	

NOTE :

1. I_{CC1}, I_{CC3}, I_{CC4}, I_{CC6} and I_{CC7} depend on cycle rate.
2. I_{CC1}, I_{CC3}, I_{CC4}, and I_{CC6} depend on output loading. Specified values are obtained with the output open.
3. I_{CC} is specified as average current. For I_{CC1}, I_{CC3} and I_{CC6}, address can be changed maximum two times while $\overline{RAS}$= V_{IL}. For I_{CC4}, address can be changed maximum once while $\overline{CAS}$= V_{IH}.
4. t_{RAS}(max.)= 1µs is only applied to refresh of battery backup but t_{RAS}(max.)= 10µs is applied to normal functional operating.
5. I_{CC5}(max.)= 7.5mA and I_{CC7} are applied to L-part only (HYM572103ALNG/ALTNG).

AC CHARACTERISTICS

(TA= 0°C to 70°C, VCC= 5V± 10%, VSS= 0V, unless otherwise noted.) NOTE : 1, 2, 3

#	SYMBOL	PARAMETER	HYM572103 N-Series						UNIT	NOTE
			-50		-60		-70			
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
1	tRC	Random Read or Write Cycle Time	90	-	110	-	130	-	ns	
2	tRWC	Read-Modify-Write Cycle Time	138	-	158	-	188	-	ns	14,15
3	tPC	Fast Page Mode Cycle Time	35	-	40	-	45	-	ns	
4	tPRWC	Fast Page Mode Read-Modify-Write Cycle Time	78	-	83	-	98	-	ns	13,15
5	tRAC	Access Time from $\overline{RAS}$	-	50	-	60	-	70	ns	4,9,10
6	tCAC	Access Time from $\overline{CAS}$	-	20	-	20	-	25	ns	4,9,15
7	tAA	Access Time from Column Address	-	31	-	36	-	41	ns	4,10,15
8	tCPA	Access Time from $\overline{CAS}$ Precharge	-	35	-	40	-	45	ns	4,15
9	tCLZ	$\overline{CAS}$ to Output Low Impedance	2	-	2	-	2	-	ns	4,13
10	tOFF	Output Buffer Turn-off Delay	0	20	0	20	0	25	ns	5,17
11	tT	Transition Time (Rise and Fall)	3	50	3	50	3	50	ns	3,12
12	tRP	$\overline{RAS}$ Precharge Time	30	-	40	-	50	-	ns	
13	tRAS	$\overline{RAS}$ Pulse Width	50	10K	60	10K	70	10K	ns	
14	tRASP	$\overline{RAS}$ Pulse Width (Fast Page Mode)	50	200K	60	200K	70	200K	ns	
15	tRSH	$\overline{RAS}$ Hold Time	20	-	20	-	25	-	ns	15
16	tCSH	$\overline{CAS}$ Hold Time	48	-	58	-	68	-	ns	14
17	tCAS	$\overline{CAS}$ Pulse Width	15	10K	15	10K	20	10K	ns	
18	tRCD	$\overline{RAS}$ to $\overline{CAS}$ Delay	13	30	18	40	18	45	ns	9,16
19	tRAD	$\overline{RAS}$ to Column Address Delay Time	8	19	13	24	13	29	ns	10,16
20	tCRP	$\overline{CAS}$ to $\overline{RAS}$ Precharge Time	15	-	15	-	15	-	ns	15
21	tCP	$\overline{CAS}$ Precharge Time	10	-	10	-	10	-	ns	
22	tASR	Row Address Set-up Time	6	-	6	-	6	-	ns	15
23	tRAH	Row Address Hold Time	3	-	8	-	8	-	ns	14
24	tASC	Column Address Set-up Time	2	-	2	-	2	-	ns	13
25	tCAH	Column Address Hold Time	17	-	17	-	17	-	ns	13
26	tAR	Column Address Hold Time from $\overline{RAS}$	43	-	48	-	53	-	ns	14
27	tRAL	Column Address to $\overline{RAS}$ Lead Time	31	-	36	-	41	-	ns	15
28	tRCS	Read Command Set-up Time	2	-	2	-	2	-	ns	13
29	tRCH	Read Command Hold Time Referenced to $\overline{CAS}$	2	-	2	-	2	-	ns	6,13
30	tRRH	Read Command Hold Time Referenced to $\overline{RAS}$	-2	-	-2	-	-2	-	ns	6,14
31	tWCH	Write Command Hold Time	12	-	17	-	17	-	ns	13
32	tWCR	Write Command Hold Time from $\overline{RAS}$	38	-	48	-	53	-	ns	14
33	tWP	Write Command Pulse Width	10	-	15	-	15	-	ns	
34	tRWL	Write Command to $\overline{RAS}$ Lead Time	20	-	20	-	25	-	ns	15
35	tCWL	Write Command to $\overline{CAS}$ Lead Time	17	-	17	-	22	-	ns	13
36	tDS	Data-In Set-up Time	-2	-	-2	-	-2	-	ns	7,14
37	tDH	Data-In Hold Time	15	-	20	-	20	-	ns	7,15
38	tDHR	Data-In Hold Time Referenced to $\overline{RAS}$	38	-	48	-	53	-	ns	14
39	tREF	Refresh Period (1024 cycles)	-	16	-	16	-	16	ms	18
		L-part	-	128	-	128	-	128		
40	tWCS	Write Command Set-up Time	2	-	2	-	2	-	ns	8,13

AC CHARACTERISTICS

(continued)

#	SYMBOL	PARAMETER	HYM572103 N-Series						UNIT	NOTE
			-50		-60		-70			
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
41	tCWD	$\overline{CAS}$ to $\overline{WE}$ Delay Time	45	-	45	-	50	-	ns	8,15
42	tRWD	$\overline{RAS}$ to $\overline{WE}$ Delay Time	73	-	83	-	98	-	ns	8,14,15
43	tAWD	Column Address to $\overline{WE}$ Delay Time	54	-	59	-	69	-	ns	8,14,15
44	tCSR	$\overline{CAS}$ Set-up Time (CBR Cycle)	10	-	10	-	10	-	ns	15
45	tCHR	$\overline{CAS}$ Hold Time (CBR Cycle)	8	-	8	-	8	-	ns	14
46	tRPC	$\overline{RAS}$ to $\overline{CAS}$ Precharge Time	-2	-	-2	-	-2	-	ns	14
47	tCPT	$\overline{CAS}$ Precharge Time (CBR Counter Test)	25	-	30	-	35	-	ns	
48	tROH	$\overline{RAS}$ Hold Time Referenced to $\overline{OE}$	15	-	15	-	15		ns	15
49	tOEA	$\overline{OE}$ Access Time	-	20	-	20	-	25	ns	15
50	tOED	$\overline{OE}$ to Data Delay	20	-	20	-	25	-	ns	15
51	tOEZ	Output Buffer Turn Off Delay Time from $\overline{OE}$	2	20	2	20	2	25	ns	5,17
52	tOEH	$\overline{OE}$ Command Hold Time	15	-	15	-	20	-	ns	
53	tCPWD	$\overline{WE}$ Delay Time from $\overline{CAS}$ Precharge	58	-	63	-	73	-	ns	8,14,15
54	tRHCP	$\overline{RAS}$ Hold Time from $\overline{CAS}$ Precharge	32	-	37	-	42	-	ns	13
55	tWRF	$\overline{WE}$ to $\overline{RAS}$ Precharge Time (CBR Cycle)	15	-	15	-	15	-	ns	15
56	tWRH	$\overline{WE}$ to $\overline{RAS}$ Hold Time (CBR Cycle)	8	-	8	-	8	-	ns	14
57	tPD	$\overline{PDE}$ to Valid Presence Detect Data	-	10	-	10	-	10	ns	11
58	tPDOFF	$\overline{PDE}$ Inactive to Presence Detects Inactive	2	-	2	-	2	-	ns	12

NOTE :

1. An initial pause of 200μs is required after power-up followed by 8 $\overline{RAS}$ cycles before proper device operation is achieved. In case of using internal refresh counter, a minimum of 8 $\overline{CAS}$-before-$\overline{RAS}$ initilization cycles instead of 8 $\overline{RAS}$-only refresh cycles are required. The device should be carefully initialized to be prevented from being entered into multi bit test mode.
2. If $\overline{RAS}$= Vss during power-up, the HYM572103 could begin an active cycle. This condition results in higher power-up current than necessary demands from the power-up. It is recommended that $\overline{RAS}$ and $\overline{CAS}$ track with V_{CC} during power-up or be held at a valid V_{IH} in order to minimize the power-up current.
3. Refer to the HY514400A and HY514403B data sheet for detailed information.
4. Measured with a load equivalent to 2 TTL loads and 100pF.
5. t_{OFF}(max.) defines the time at which the output achieves the open circuit condition and is not referenced to output voltage levels.
6. Either t_{RCH} or t_{RRH} must be satisfied for a read cycle.
7. These parameters are referenced to $\overline{CAS}$ leading edge in early write cycles.
8. t_{WCS} is not a restrictive operating parameter. It is included in the data sheet as electrical characteristics only. If $t_{WCS} \geq t_{WCS}$(min.), the cycle is an early write cycle and data out pin will remain open circuit (high impedance) through the entire cycle.
9. Operation within the t_{RCD}(max.) limit insures that t_{RAC}(max.) can be met. t_{RCD}(max.) is specified as a reference point only. If t_{RCD} is greater than the specified t_{RCD}(max.) limit, then access time is controlled by t_{CAC}.
10. Operation within the t_{RAD}(max.) limit insures that t_{RAC}(max.) can be met. t_{RAD}(max.) is specified as a reference point only. If t_{RAD} is greater than the specified t_{RAD}(max.) limit, then access time is controlled by t_{AA}.
11. Measured with the specified current load and 100pF.
12. t_{PDOFF}(max.) is determined by the pull-up resistor value. Care must be taken to ensure adequate recovery time prior to reading valid up-level on subsequent SIMM position.
13. A + 2ns timing skew from the DRAM to the DIMM resulted from the addition of buffers (DRAM loading may add to skew).
14. A -2ns timing skew from the DRAM to the DIMM resulted from the addition of buffers (DRAM loading may add to skew).
15. A + 5ns ($\overline{CAS}$,$\overline{WE}$,$\overline{OE}$) or + 6ns (address) timing skew from the DRAM to the DIMM resulted from the addition of buffers. (DRAM loading may add skew).
16. A -2ns min and a -5ns ($\overline{CAS}$,$\overline{WE}$,$\overline{OE}$) or -6ns (address) max timing skew from the DRAM to the DIMM resulted from the addition of buffers. (DRAM loading may add to skew).
17. A + 2ns min and a + 5ns ($\overline{CAS}$,$\overline{WE}$,$\overline{OE}$) or + 6ns (address) max timing skew from the DRAM to the DIMM resulted from the addition of buffers. (DRAM loading may add to skew).

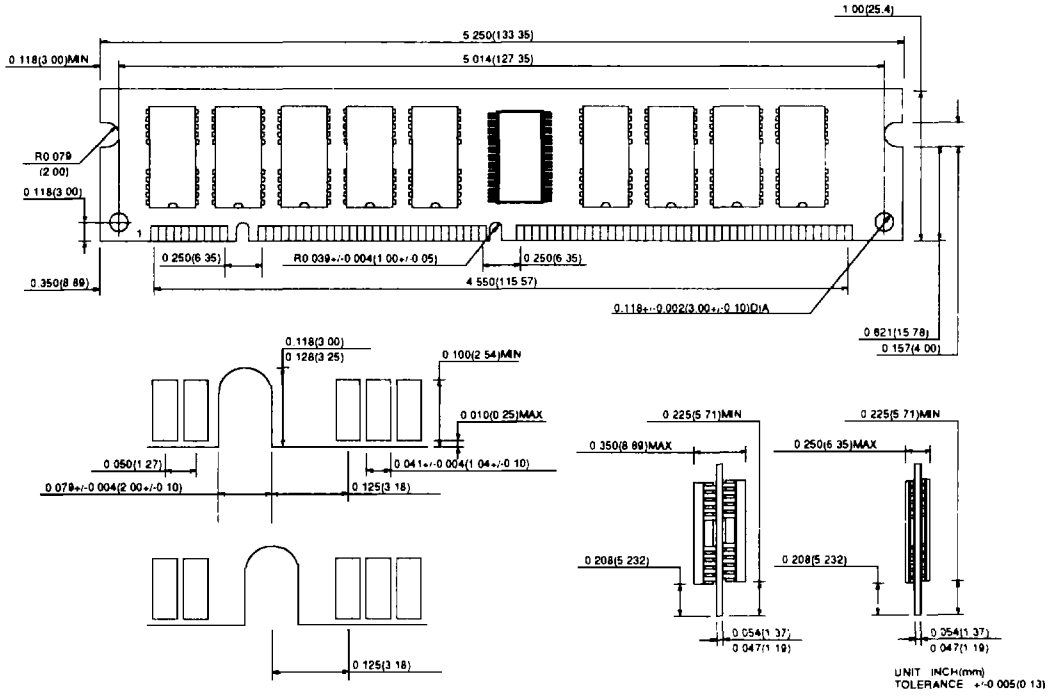
CAPACITANCE

(T_A= 25°C, V_{CC}= 5V± 10%, V_{SS}= 0V, f= 1MHz, unless otherwise noted.)

SYMBOL	PARAMETER	TYP.	MAX.	UNIT
C_{IN1}	Input Capacitance (A0-A9,B0)	-	13	pF
C_{IN2}	Input Capacitance ($\overline{RAS0}$,$\overline{RAS2}$)	-	70	pF
C_{IN3}	Input Capacitance ($\overline{CAS0}$-$\overline{CAS7}$,$\overline{WE0}$,$\overline{WE2}$,$\overline{OE0}$,$\overline{OE2}$)	-	13	pF
C_{DQ}	Data Input/Output Capacitance (DQ0-DQ71)	-	15	pF

PACKAGE INFORMATION

168 pin Dual In-line Memory Module (NG ; Gold plated)



ORDERING INFORMATION

PART NUMBER	SPEED	POWER	PACKAGE	PLATING
HYM572103NG	50/60/70		DIMM	Gold
HYM572103LNG	50/60/70	L-part	DIMM	Gold
HYM572103TNG	50/60/70		DIMM	Gold
HYM572103LTNG	50/60/70	L-part	DIMM	Gold